Applicant(s)/Patent Under Application/Control No. Reexamination 10/636,075 LEE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 3728 David T. Fidei **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,803,253 A 09-1998 Zakarian, Arthur 206/349 Α US-6,206,189 B1 03-2001 206/379 В Huot et al. С US-D US-Ε US-F US-US-G US-Н US-1 J US-Κ US-US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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